Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/536,456	OKADO, HIRONORI	
Examiner	Art Unit	
Shih-Chao Chen	2821	

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	SEARCHED			
Class	Subclass	Date	Examiner	
343	700MS, 767, 846	6/14/2006	CHEN	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC		·)
	DATE	EXMR
EAST (See attached printout).	6/14/2006	CHEN
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